

DUAL 4-5 INPUT OR/NOR GATE 10109

10109B,F: -30 to +85°C

DIGITAL 10,000 SERIES ECL

DESCRIPTION

The 10109 is a high speed 4-input OR/NOR and 5-input OR/NOR dual gate. All inputs are terminated with a 50 k Ω resistor to VEE which eliminates the need to tie unused inputs low. The gate has an excellent speed-power product of 50 picojoules. The 10109 is optimized for high performance logic applications. The 10109 has complementary outputs.

FEATURES

- FAST PROPAGATION DELAY = 2.0 ns TYP
- LOW POWER DISSIPATION = 50 mW/PACKAGE TYP (NO LOAD)
- HIGH FANOUT CAPABILITY
 CAN DRIVE 50 Ω LINES
- HIGH Z INPUTS INTERNAL 50 kΩ PULLDOWNS
- HIGH IMMUNITY FROM POWER SUPPLY VARIA-TIONS: VEE = -5.2 V ±5% RECOMMENDED
- COMPLEMENTARY OR/NOR OUTPUTS
- OPEN EMITTERS FOR BUSSING AND LOGIC CAPABILITY

LOGIC DIAGRAM



TEMPERATURE RANGE

• -30 to +85°C Operating Ambient

PACKAGE TYPE

B: 16-Pin Silicone DIP

F: 16-Pin CERDIP

CIRCUIT SCHEMATIC



LECTRICAL CHARACTERISTICS											TEST VOLTAGE VALUES					
at I leter Malanes and Ambient Tennessee										@ Test	(Valts)					
at Listed Voltages and Ambient Temperatures).										VIH max	ViL min	VIHA min	VILA max	VEE		
										-30° C	0.890	-1.890	-1.205	-1.500	-6.2]
										+26°C	-0.810	-1.850	-1.105	-1.476	-6.2	1
										+86° C	-0.700	-1.825	-1.036	-1.440	-6.2	1
Characteristic	Symbol	Pin Under Test	10109 Test Limite								TEST VOLTAGE APPLIED TO PINS BELOW:					1
			-30° C		+26°C			+86°C							r	(Vcc
			Min	Мех	Min	Тур	Mex	Min	Max	Unit	VIH max	Vil. min	VIHA min	VILA max	VEE	Gnd
Power Supply Drain Current	1E	8	-	-	-	10	14	-	-	mAdc	-	-	-	-	8	1,16
Input Current	4nH	4	-	-	-	-	266	-	-	µAdc	4	T	-	T	8	1,10
	linL	4	-	-	0.5	-	-	-	-	μAdc		4		-	A	1,10
High Output Voltege	VOH	2	-1.060	-0.890	-0.960	-	-0.810	-0 890	~0.700	Vdc	* 4	-	-	-	8	1,1
		3	-1.060	-0.890	-0.960	-	-0.810	-0.890	0.700	Vdc	-	4	-		8	1,10
Low Output Voltage	VOL	2	-1.890	-1.676	-1.850	-	~1.650	-1.826	-1.616	Vdc	-	4	-	-	8	1,16
		3	~1.890	-1.675	-1.860	-	-1.650	-1.826	-1.615	Vdc	4	-	-	-	8	1,16
High Threshold Voltage	VOHA	2	-1.080	-	-0.980	1	-	-0.910	-	Vdc	-		4	-	8	1,16
		3	-1.080	-	-0.980	-	-	-0.910	-	Vdc	-		-	4	8	1,10
Low Threshold Voltage	VOLA	2	-	-1.665	-	-	-1.630	-	1.695	Vdc	-	-	-	4	8	1,16
		3	-	-1.666	1	-	-1.630	-	-1.696	Vdc	1.4.1	-	4	-	8	1,16
Switching Times *													Puise in	Pulse Out	-3.2 V	+2.0
Propagation Delay	14+ 2+	2	1.0	3.1	1.0	2.0	2.9	1.0	3,3	ns	-	-	4	2	8	1,16
	14-2-	2		1			11	11	L Î		-	-		2		
	14+3-	3									-			3		
	14-3+	3		1 1	1.1						-	-		3		
Fise Time (20% to 80%)	12+	2	ú	3.0	1.1		3.3	1.1	3.7		÷ .	-		2	11	
	13+	3	11				1.1	1 1			_			3		
Fell Time (20% to 80%)	12-	2					11	1			-	-		2		
	13_	3										-		3		

*Unused outputs connected to a 50-ohm resistor to ground.

SWITCHING TIME TEST CIRCUIT



PROPAGATION DELAY WAVEFORMS @ 25°C



NOTES:

- Each ECL 10,000 series device has been designed to meet the DC specifications shown in the test table, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 linear fpm is maintained. Voltage levels will shift approximately 2 mV with an air flow of 200 linear fpm. Outputs are terminated through a 50-ohm resistor to 2.0 volts.
- 2. For AC tests, all input and output cables to the scope are equal lengths of 50-ohm coexial cable. Wire length should be < 1/4 inch from TP_{in} to input pin and TP_{out} to output pin. A 50-ohm termination to ground is located in each scope input. Unused outputs are connected to a 50-ohm resistor to ground.
- 3. Test procedures are shown for only one input or set of input conditions. Other inputs are tested in the same manner.
- 4. All voltage measurements are referenced to the ground terminal. Terminals not specifically referenced are left electrically open.